## Notice of References Cited Application/Control No. 10/785,669 Examiner Hai Vo Applicant(s)/Patent Under Reexamination HAALAND, RODNEY S. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,514,504	04-1985	Rothman, Alan M.	436/85
*	В	US-4,318,437	03-1982	Kemp, Willard E.	164/7.2
*	С	US-4,147,821	04-1979	Young, Peter D.	427/295
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-	, , , ,		
	K	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

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L	*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
		U				
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		W				
		x				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.